

Notice of References Cited

Application/Control No.

10/089,674

Applicant(s)/Patent Under Reexam

Lee

Examiner

R.S. Travers J.D., Ph.D.

Art Unit

1617

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U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification ²	
		Country Code-Number-Kind Code	MM-YYYY ¹			
	A	4,914,131	4/1990	Haines et al	514	626
	B					
	C					
	D					
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	M					

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*		Document Number	Date	Country	Name	Classification ²	
		Country Code-Number-Kind Code	MM-YYYY ¹				
x	N	0 316 117	5/1989	EPO	Shenfeld	CO7F	9/10
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x	P	0 572 922	5/1993	EPO	Weischer et al	A61K	31/385
x	Q	WO 91/03246	3/1991	WIPO	Pauza et al	A61K	31/59
	R						
	S						
	T						

NON-PATENT DOCUMENTS

*	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages						
	U	Asanaka et al, 112CA:232458, 1990					
	V						
	W						
	X						

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.² Classifications may be U.S. or foreign.